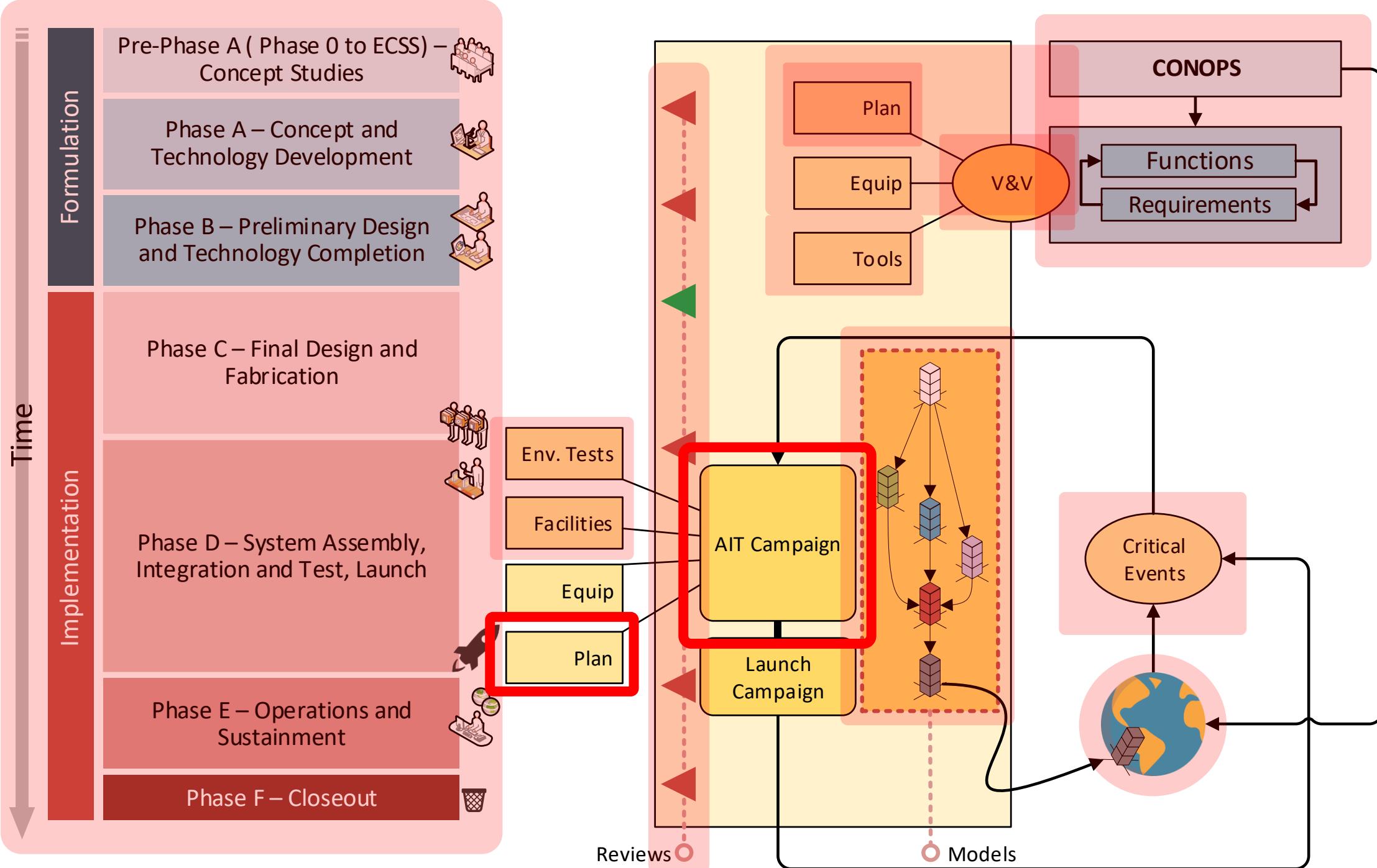




AIT PLanning

[SIS-08][LEC-011]





Date	SES	In Class	Deliverables
Aug, 1	01	[LEC-000] Course Introduction [LEC-001] SE Review	-
Aug, 8	02	[LEC-002] Global Verification Process	[PRD-001] System Description & Architecture
Aug, 15	03	[LEC-003] Tool and Processes to Verification	[PRD-002] System DSM Product Tree
Aug, 22	04	[LEC-004] Life Cycle, Reviews & Baselines	[PRD-003] Revised Requirements
Aug, 29	05	[LEC-005] Model Philosophy	[PRD-004] Verifications per Requirement through the Life Cycle
Sep, 5	06	[LEC-006] Preparing to test Campaigns	[PRD-005] Models
Sep, 12	07	[LEC-007] Planning V&V	[PRD-006] Test Articles, Procedures & VCD
Sep, 19	08	[TST-001] V&V Conceptual Questions [PRD-007] DRAFT V&V Plan Presentation	[PRD-007] DRAFT V&V Plan (DVM)
Sep, 26		Week off	
Oct, 03	09	[LEC-008] AIT Process	[PRD-008] End to End Test Articles
Oct, 10	10	[LEC-009] Critical Events & Environmental Tests	[PRD-009] AIT Activities through the Life Cycle
Oct, 17	11	[LEC-010] Testing Facilities	[PRD-010] Vehicle and On-Orbit Testing
Oct, 24	12	[LEC-011] Planning AIT	[PRD-011] Facilities
Oct, 31	13	[LEC-012] GSEs [LEC-013] SCOE/OCOE	[PRD-012] AIT Flows & Activity Log
Nov, 07	14	[LEC-014] Launching Campaign	[PRD-013] GSEs
Nov, 14	15	[LEC-015] Trends / MBSE / Industry 4.0	[PRD-014] AIT Task Sheets [PRD-015] Vehicle Integration & Launching Plan
Nov, 21	16	[TST-002] AIT Conceptual Questions [PRD-016] V&V & AIT Plans Presentation	[PRD-016] V&V & AIT Plans
Nov, 28		EXAM: Design of an AIT Facility to ITA's SmallSat Projects	
Dez, 05			

CONOPS

Oct, 17th – 10 – Events + Facilities
 Oct, 31th – 11 – Planning
 Nov, 07th – 12 – Equips
 Nov, 08th – 13 – Launching
 Nov, 14th – 14 – Ending
 Nov, XX?th – 15 – TST-002
 Nov, 21th – 16 – CEI-AIT

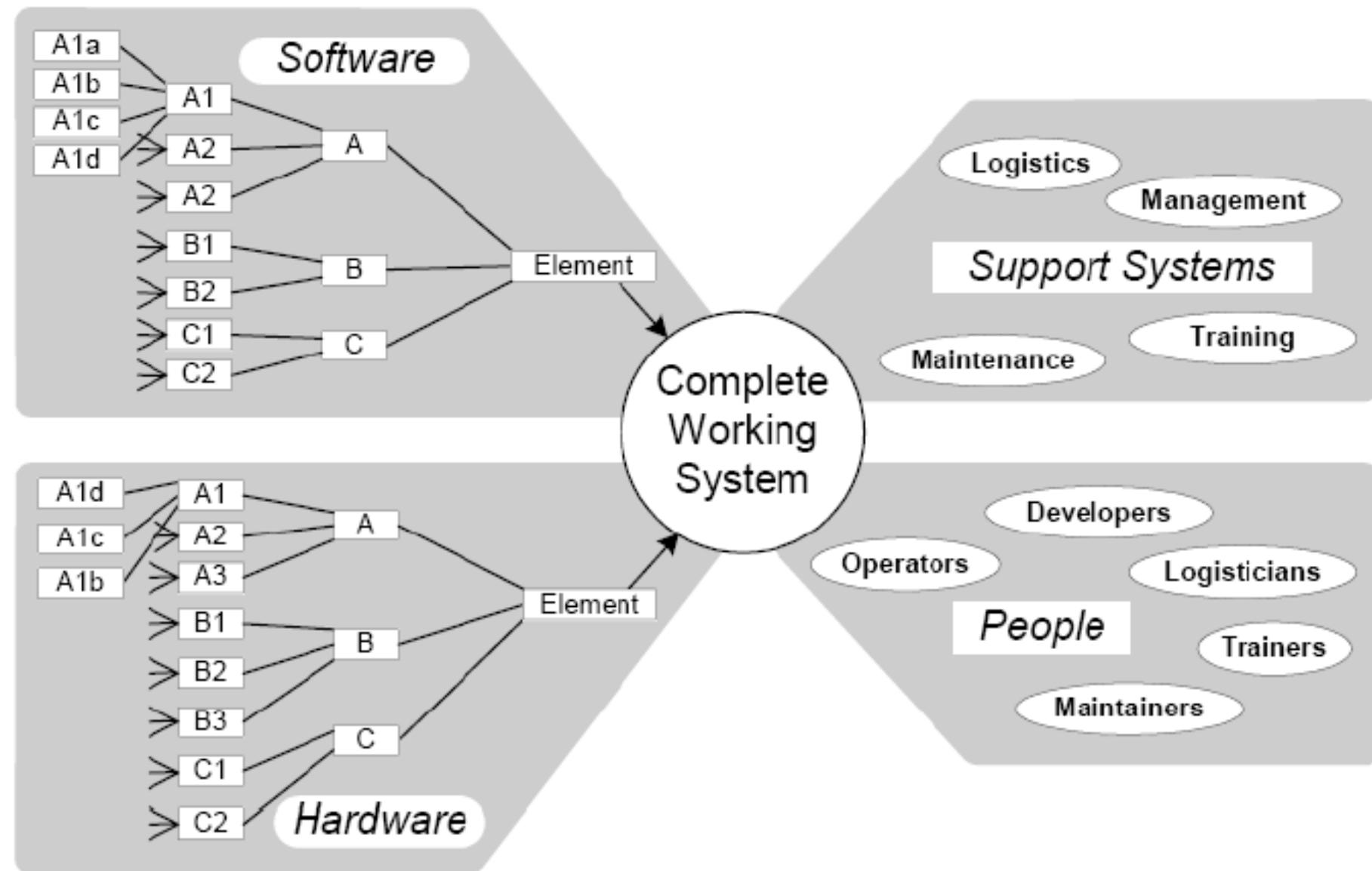


GOAL OF INTEGRATION

- The goal of integration **is to reduce the project risk of being late or the risk of creating an ill performing system.**
- During integration, the project team tries to find unforeseen problems as early as possible, in order to solve these problems in time. **Integration plays a major role in risk reduction.**
- **Problems can be unforeseen**
 - because the knowledge of the creation team is limited.
 - due to invalid assumptions. For instance many assumptions are being made early in the design to cope with many uncertainties.
 - problems is interference between functions or components of system.

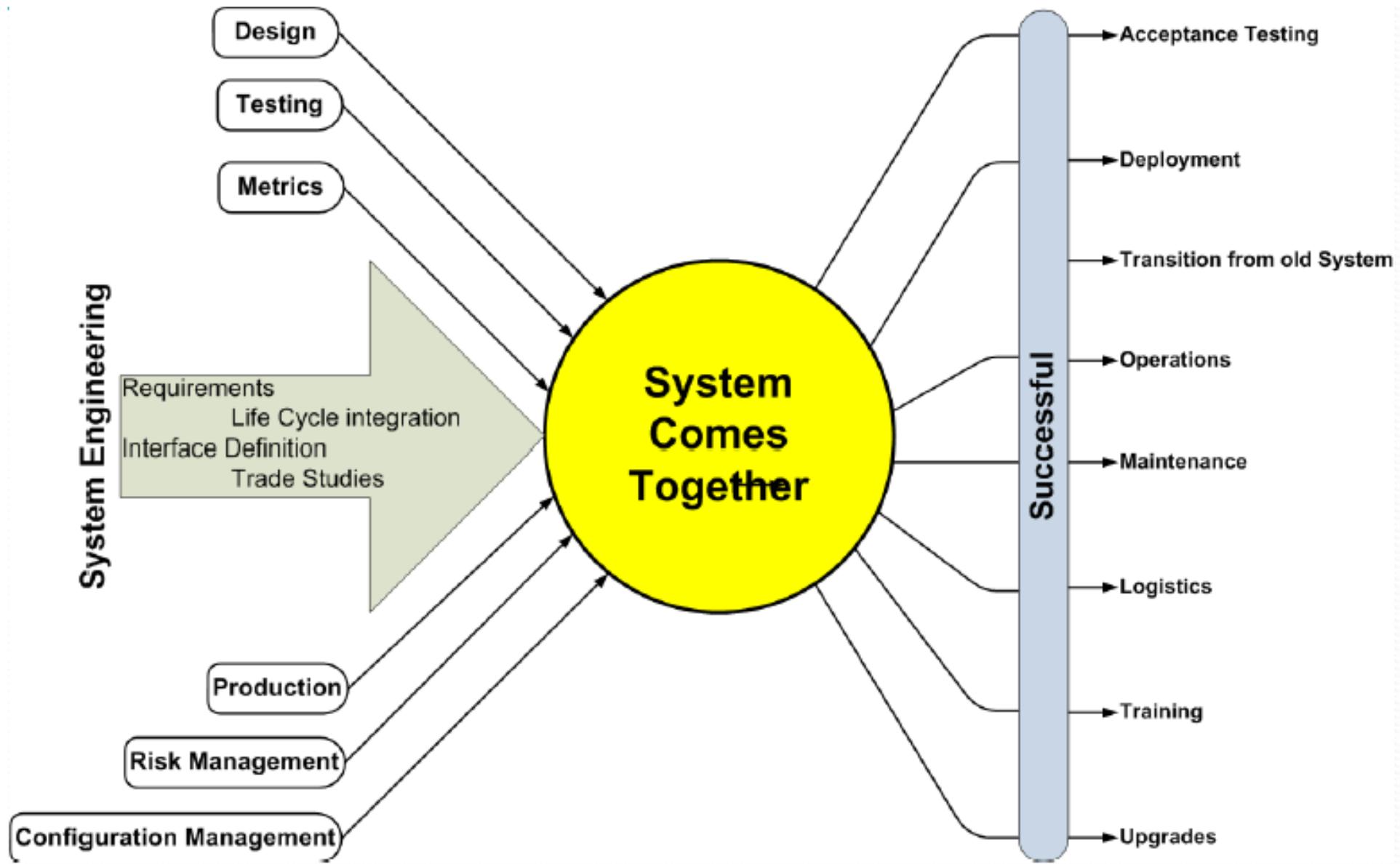


SYSTEM INTEGRATION - IMPLEMENTATION



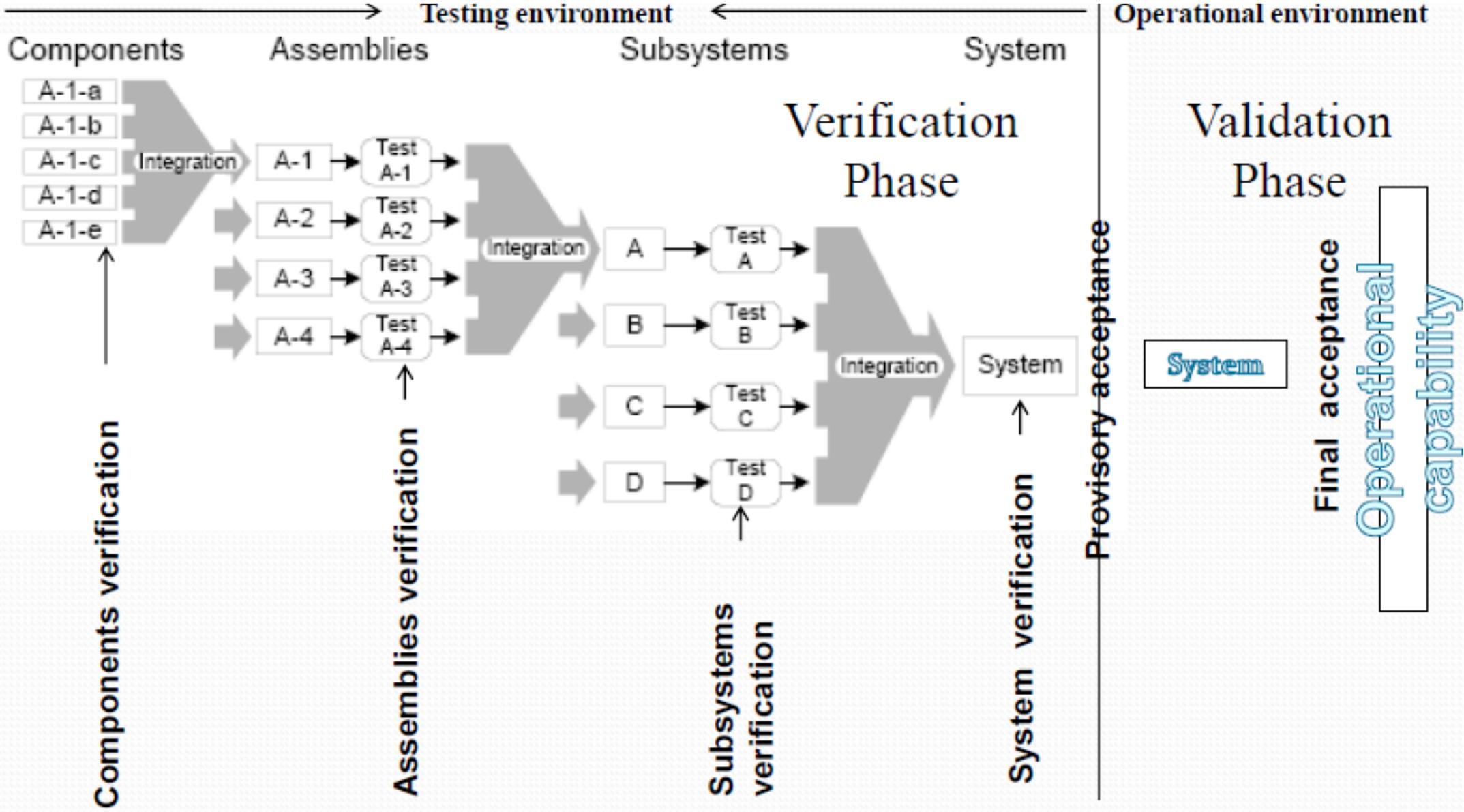


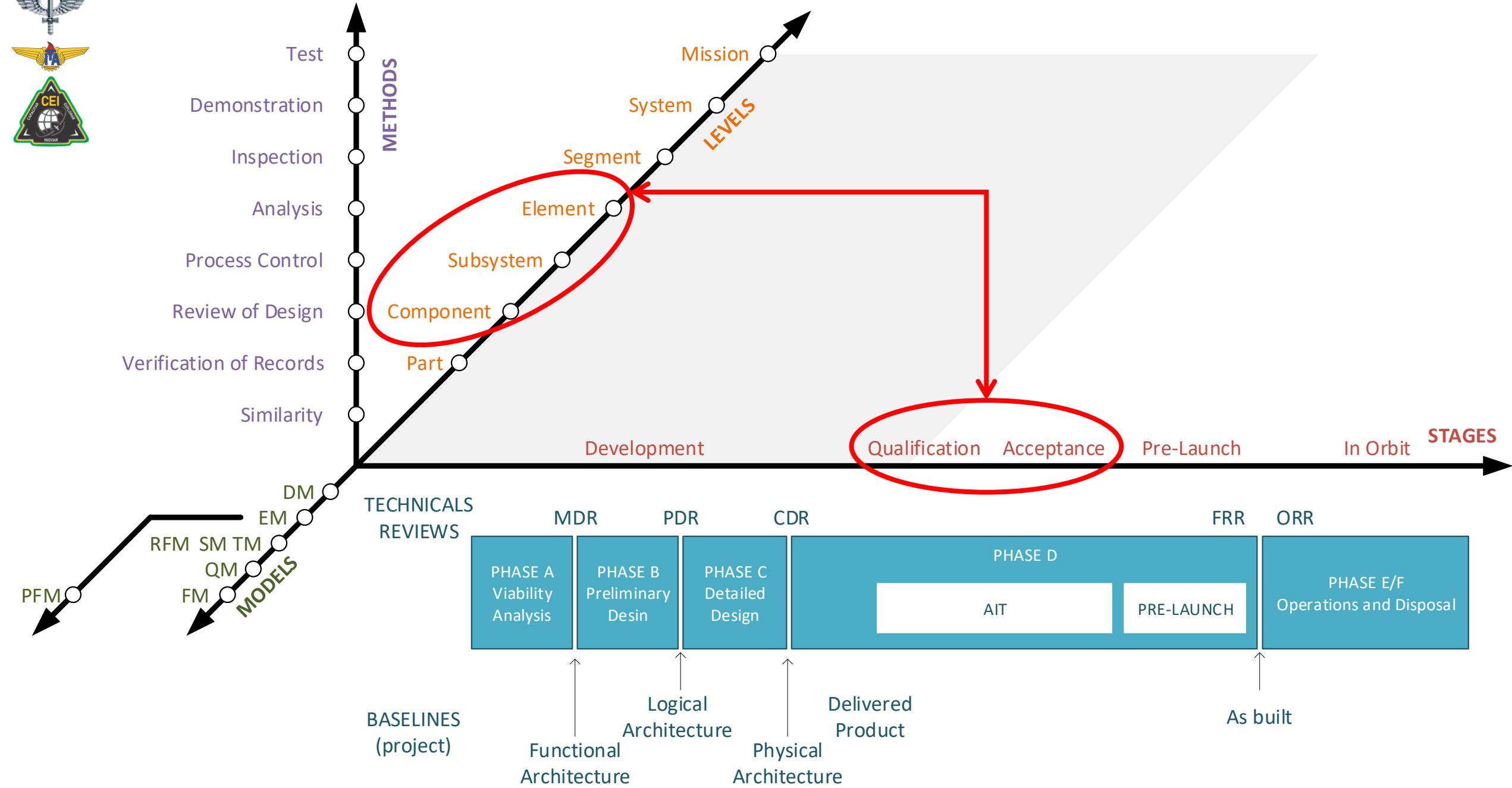
SYSTEM INTEGRATION - IMPLEMENTATION





SYSTEM INTEGRATION – VERIFICATION LEVELS







AESP-14 Example CASE

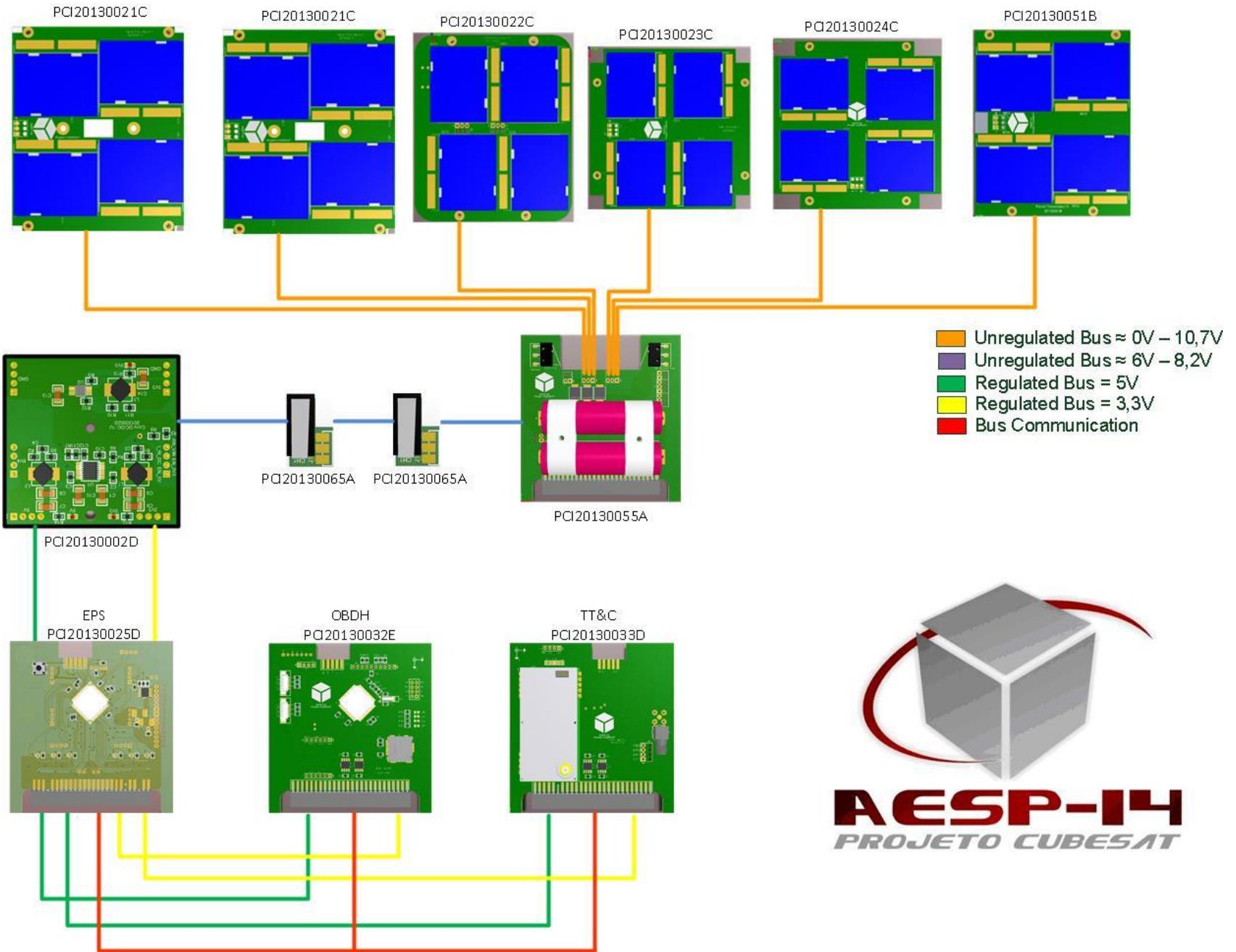
PROPOSTA DE MÉTODO PARA AIT DE PICO E NANOSSATÉLITES

Eduardo Escobar Bürger

Dissertação de Mestrado do Curso de Pós-Graduação em Engenharia e Tecnologia Espaciais/Gerenciamento de Sistemas Espaciais, orientada pelo Dr. Geilson Loureiro, aprovada em 24 de Fevereiro de 2014.

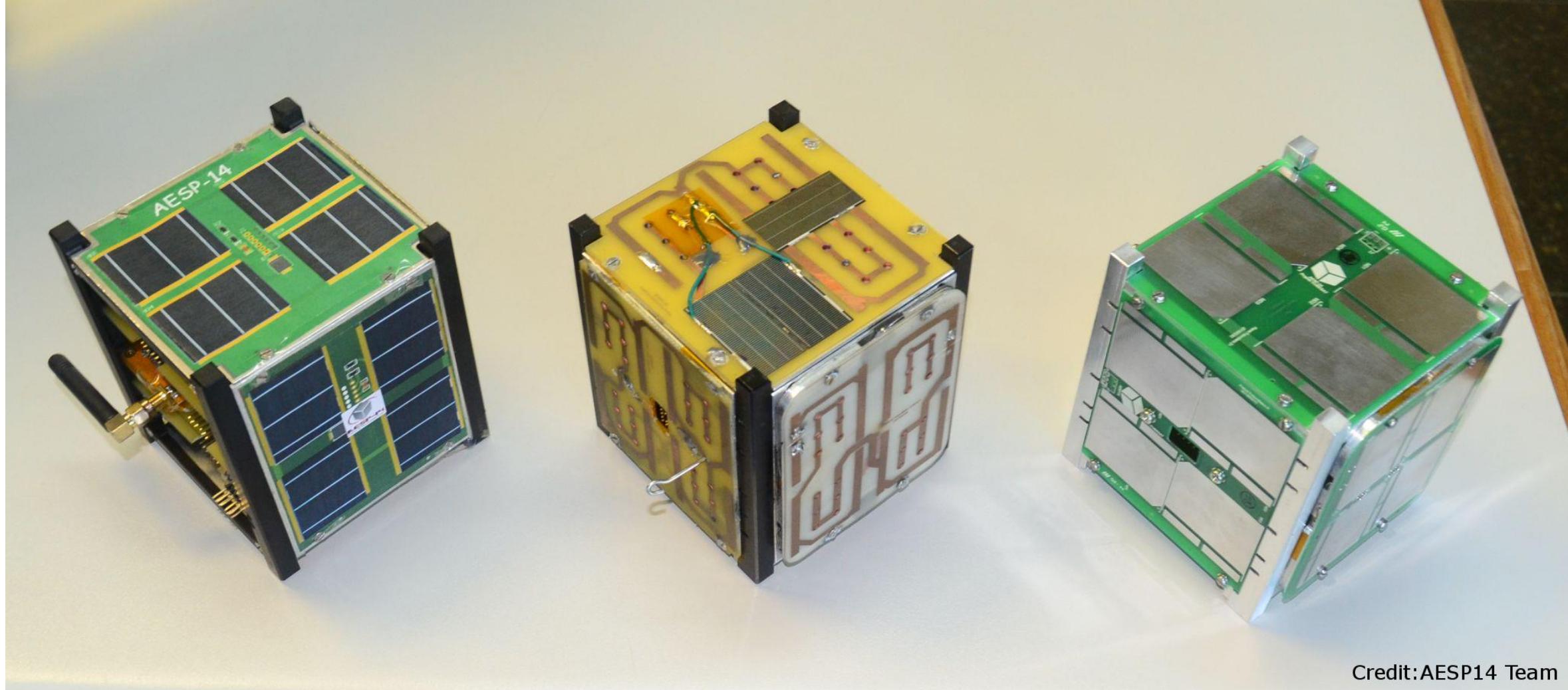


Satellite AESP-14 Architecture Diagram





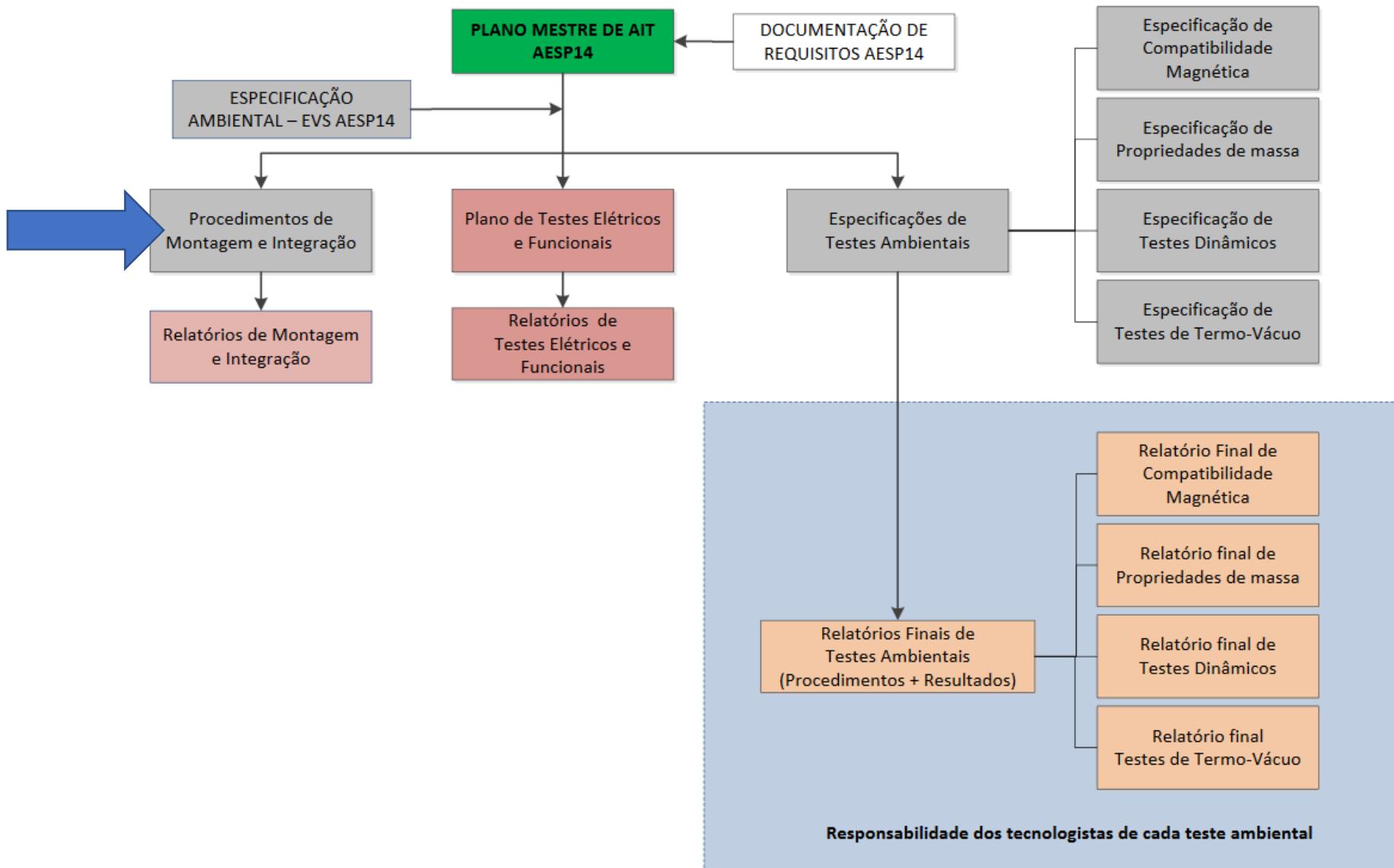
MODELOS



Credit:AESP14 Team

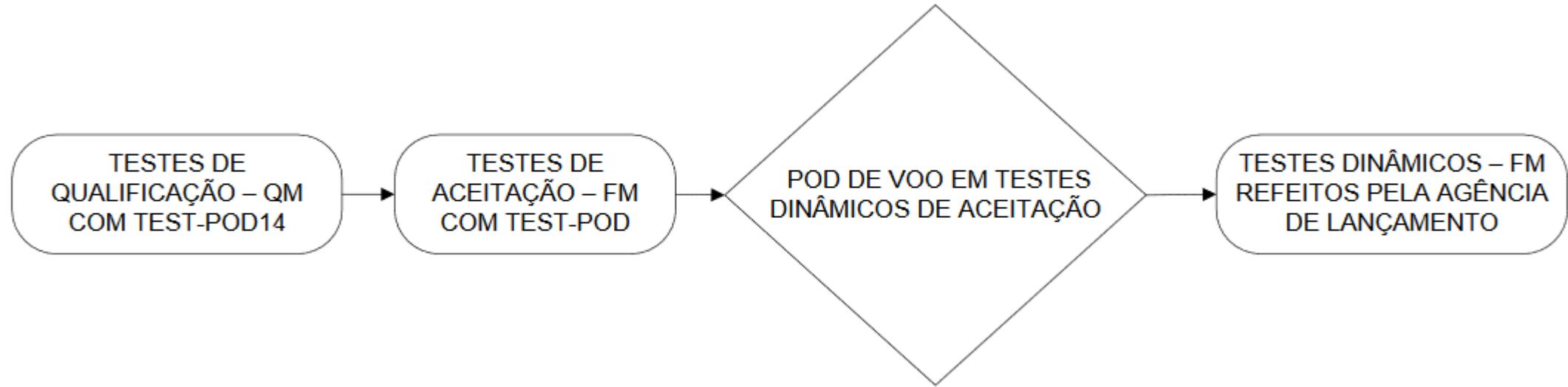


Estrutura geral da documentação de AIT do AESP14





Macro Sequência de testes do Projeto AESP14



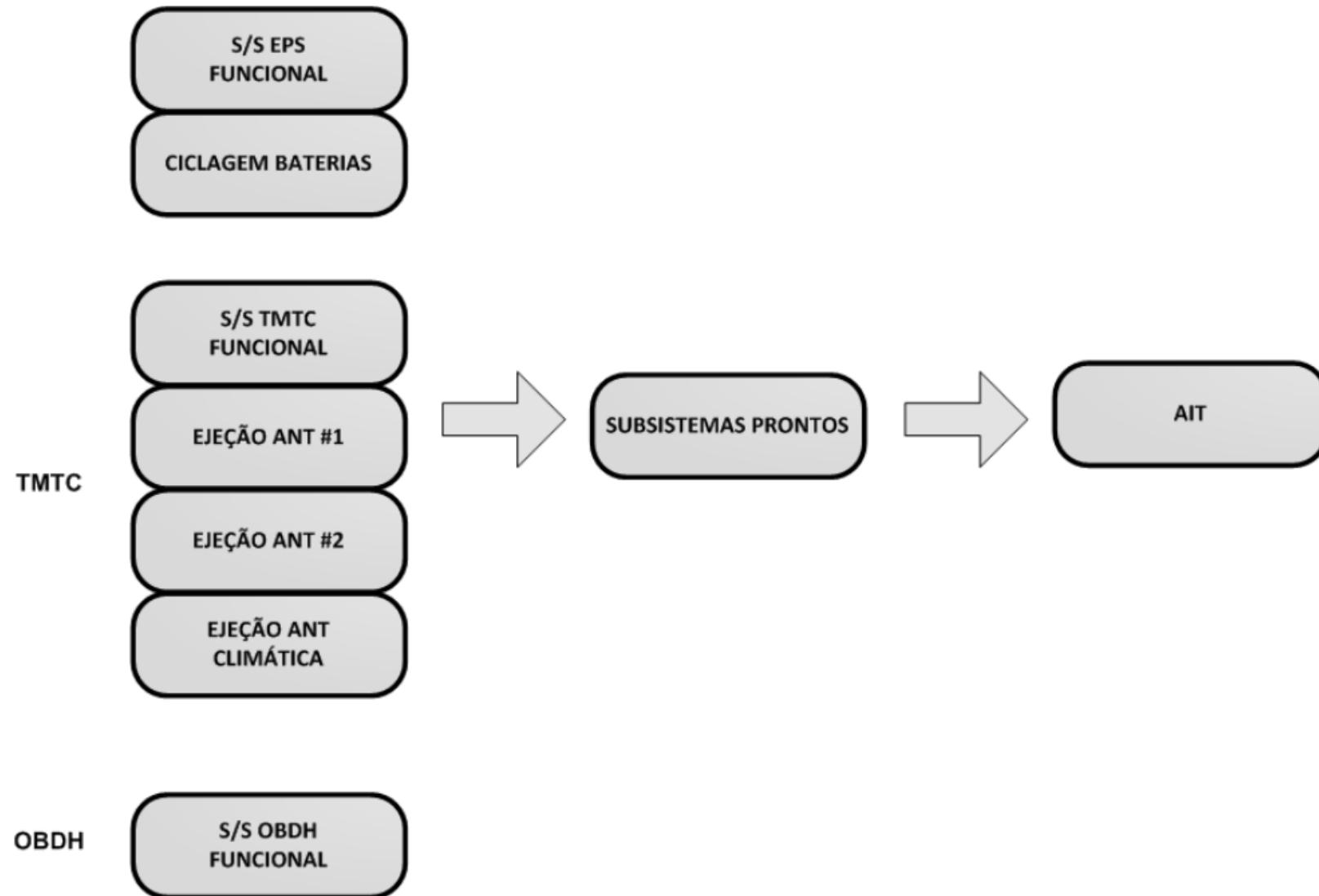


Testes x Modelos

Testes Sistêmicos	QM	FM
Check Funcional	X	X
Teste Funcional Baseline/Final	X	X
Teste EMC	X	
Propriedades de Massa	X	X
Assinatura	X	X
Teste de Choque	X	
Teste Randômico	X	X
Teste Senoidal	X	X
Teste Quase estático	X	X
Teste de Ciclagem Térmica no Vácuo	X	X
Bake-out	X	X



Testes de subsistema -QM





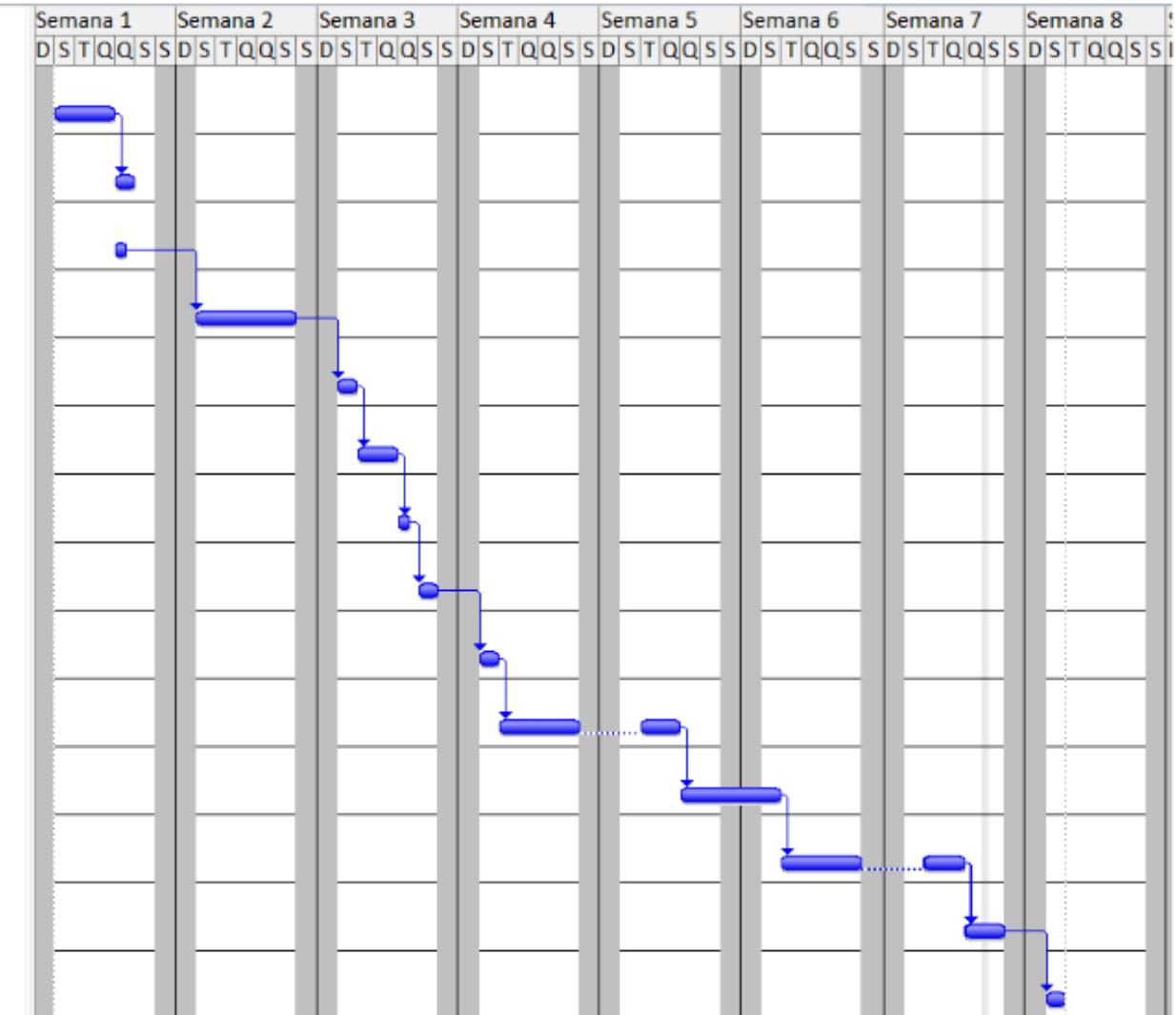
Matriz de requisitos de AIT.

ID	REQUISITOS DE TESTE	ESTÁGIO DE VERIFICAÇÃO		MÉTODO DE VERIFICAÇÃO	CRITÉRIO DE VERIFICAÇÃO
		Q	A		
	REQUISITOS DE TESTES DINÂMICOS				
2-03-001-01	O AESP14 deve ser capaz de manter sua integridade mecânica e funcional perante os testes dinâmicos nos três eixos ortogonais com níveis especificados no EVS-AESP14.	X	X	Testes dinâmicos / Testes funcionais /Teste de Mecanismos	O AESP14 deve manter sua integridade mecânica e funcional.
2-03-001-01-01	O AESP14 deve ser capaz de manter sua integridade mecânica e funcional perante o teste de choque de qualificação nos três eixos ortogonais, com níveis especificados no	X		Teste de Choque	O AESP14 deve manter sua integridade mecânica e funcional.



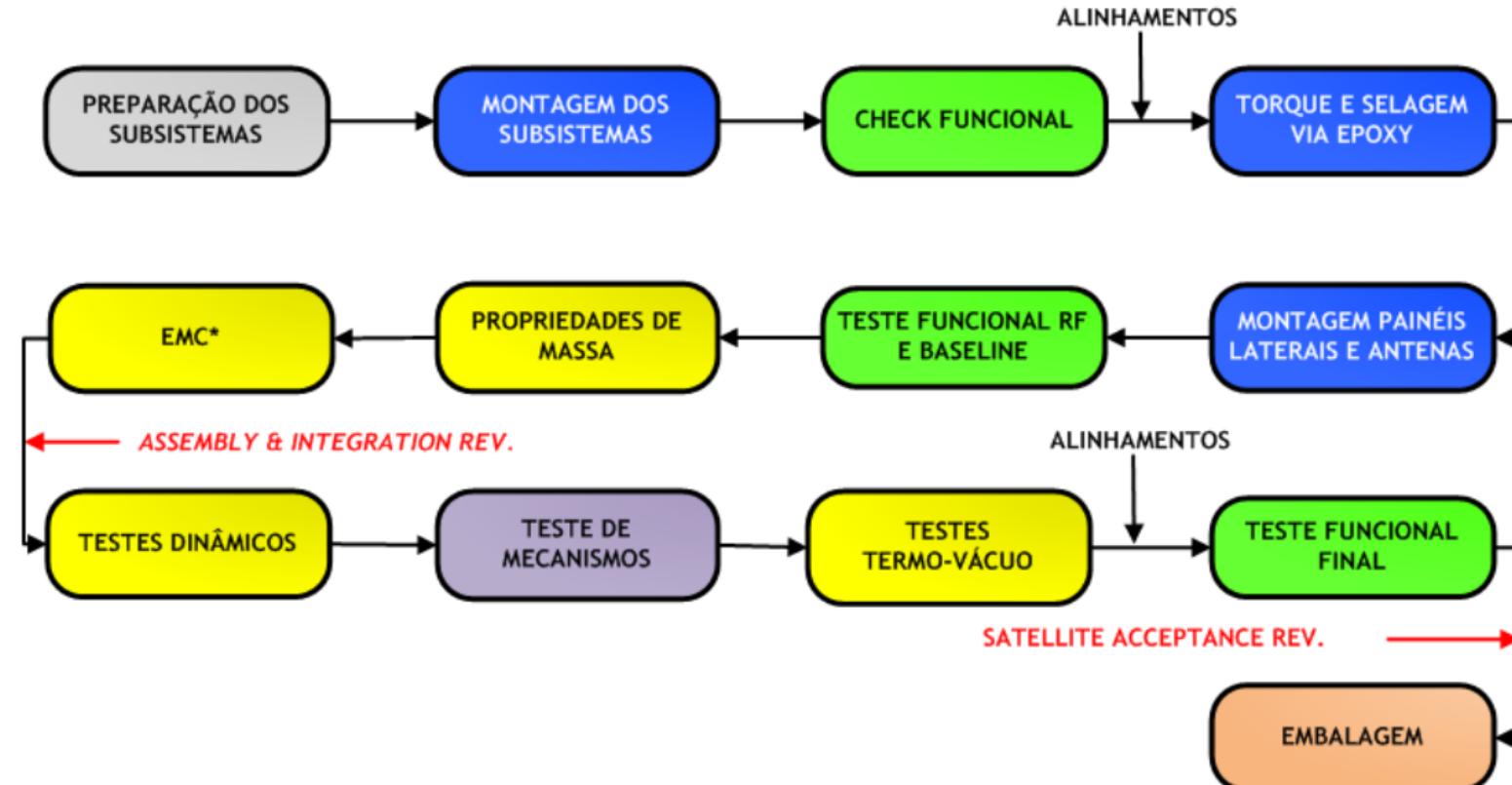
Gráfico de Gannt das atividades de AIT

	Nome da tarefa	Duração
1	Preparação dos Subsistemas	3 dias
2	Montagem dos Subsistemas	1 dia
3	Check Funcional	0,5 dias
4	Torque e Selagem via Epoxy	5 dias
5	Montagem Painéis Laterais e Antenas	1 dia
6	Teste Funcional RF e Testes Funcional Baseline	2 dias
7	Propriedades de Massa	0,5 dias
8	EMC	1 dia
9	Assembly & Integration Review (AIR)	1 dia
10	Testes Dinâmicos	6 dias
11	Teste de Mecanismos	3 dias
12	Testes de Termo-Vácuo	6 dias
13	Teste Funcional Final	2 dias
14	Embalagem	1 dia





SEQUÊNCIA GERAL DE AIT–QM E FM



*Realizado apenas no QM.



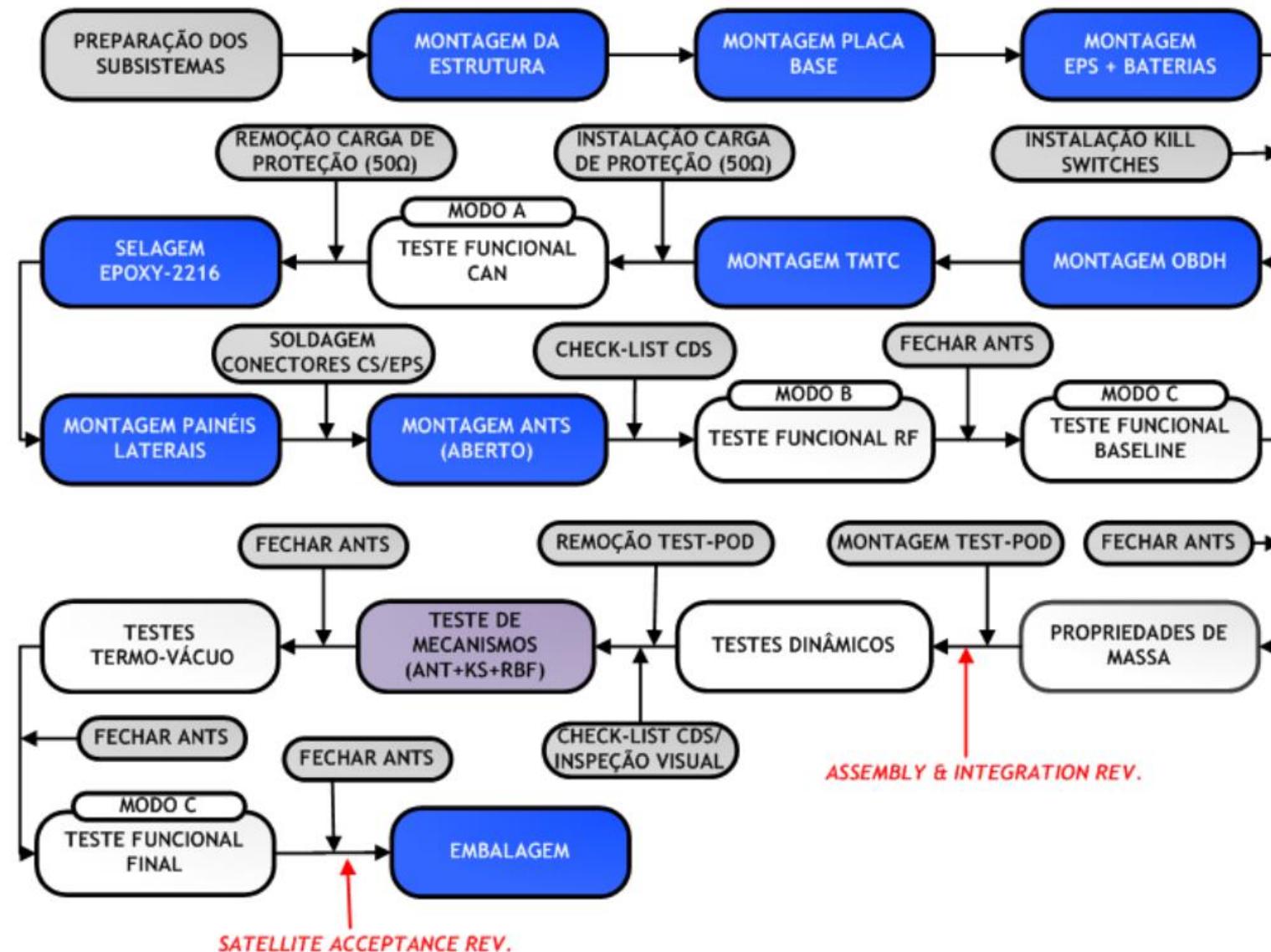
Modos

- Modo A –Verificação da comunicação básica via protocolo CAN;
- Modo B –Verificação das funções de comunicação via RF;
- Modo C –Teste de simulação de voo com todas as funções, desempenho e interação entre S/S via RF

		MODOS			
		A	B	C	
Configuração do CubeSat	Subsistemas	X			
	Subsistemas + Painéis laterais + Antenas		X	X	
Monitoramento e Controle	Cabos	Umbilical – S/C	X	X	
				X	
Fonte de Alimentação	Antenas			X	
	Baterias		X	X	
EGSE	Fonte		X	X	
	EGSE CubeSat		X	X	
	EGSE COTS do módulo RF			X	

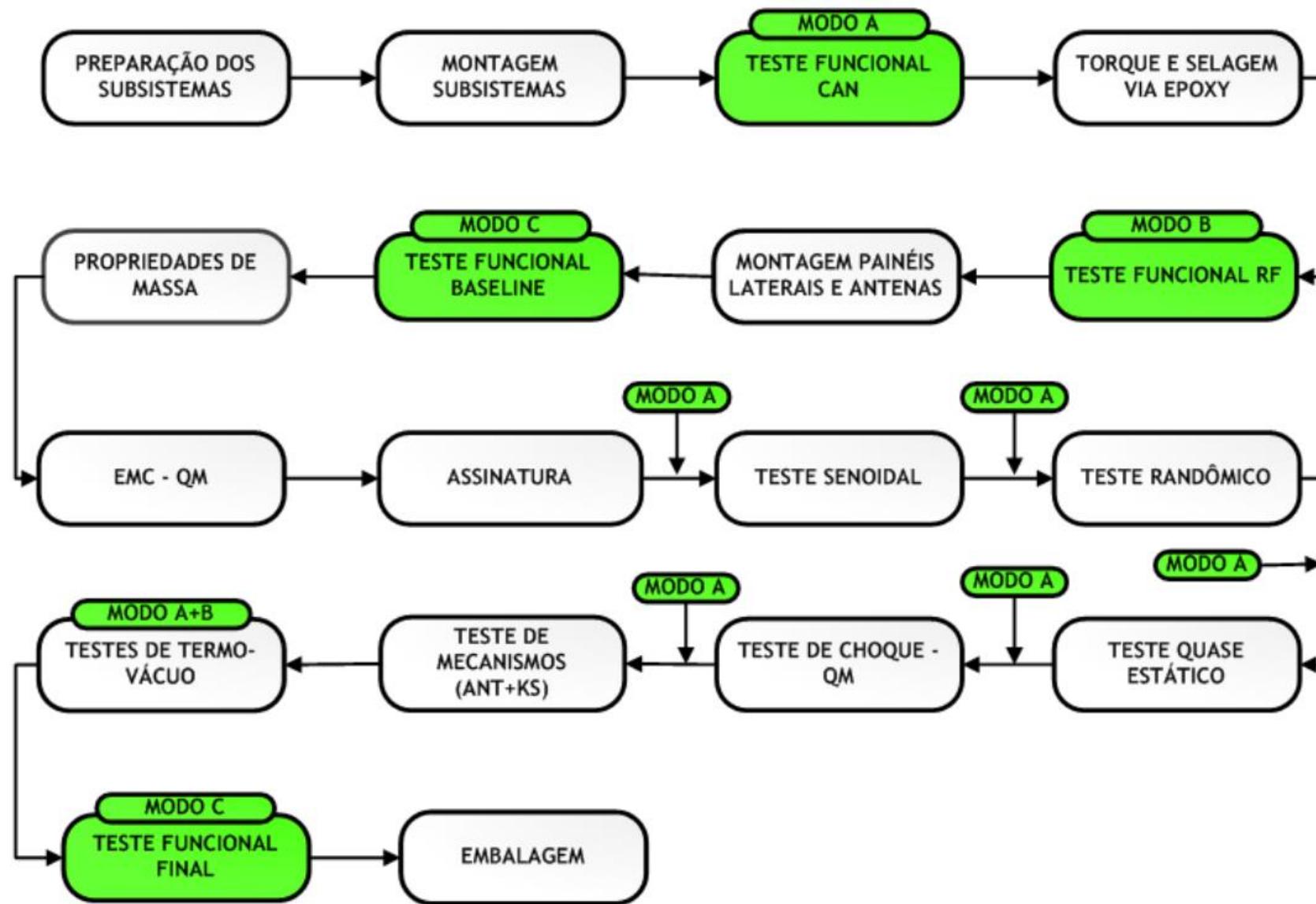


SEQUÊNCIA DE MONTAGEM E INTEGRAÇÃO – QM E FM



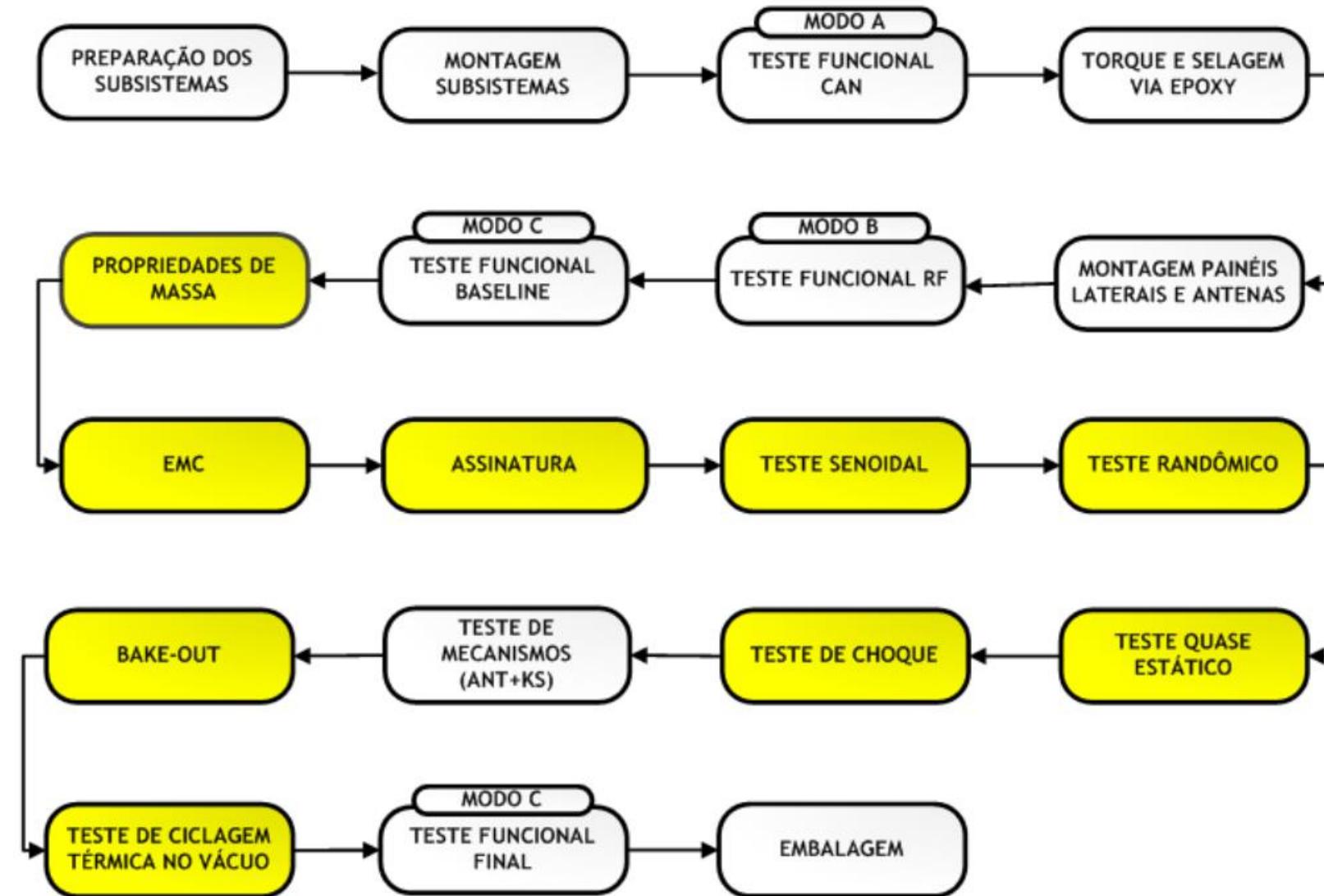


SEQUÊNCIA GERAL DE TESTES ELÉTRICOS E FUNCIONAIS –QM E FM



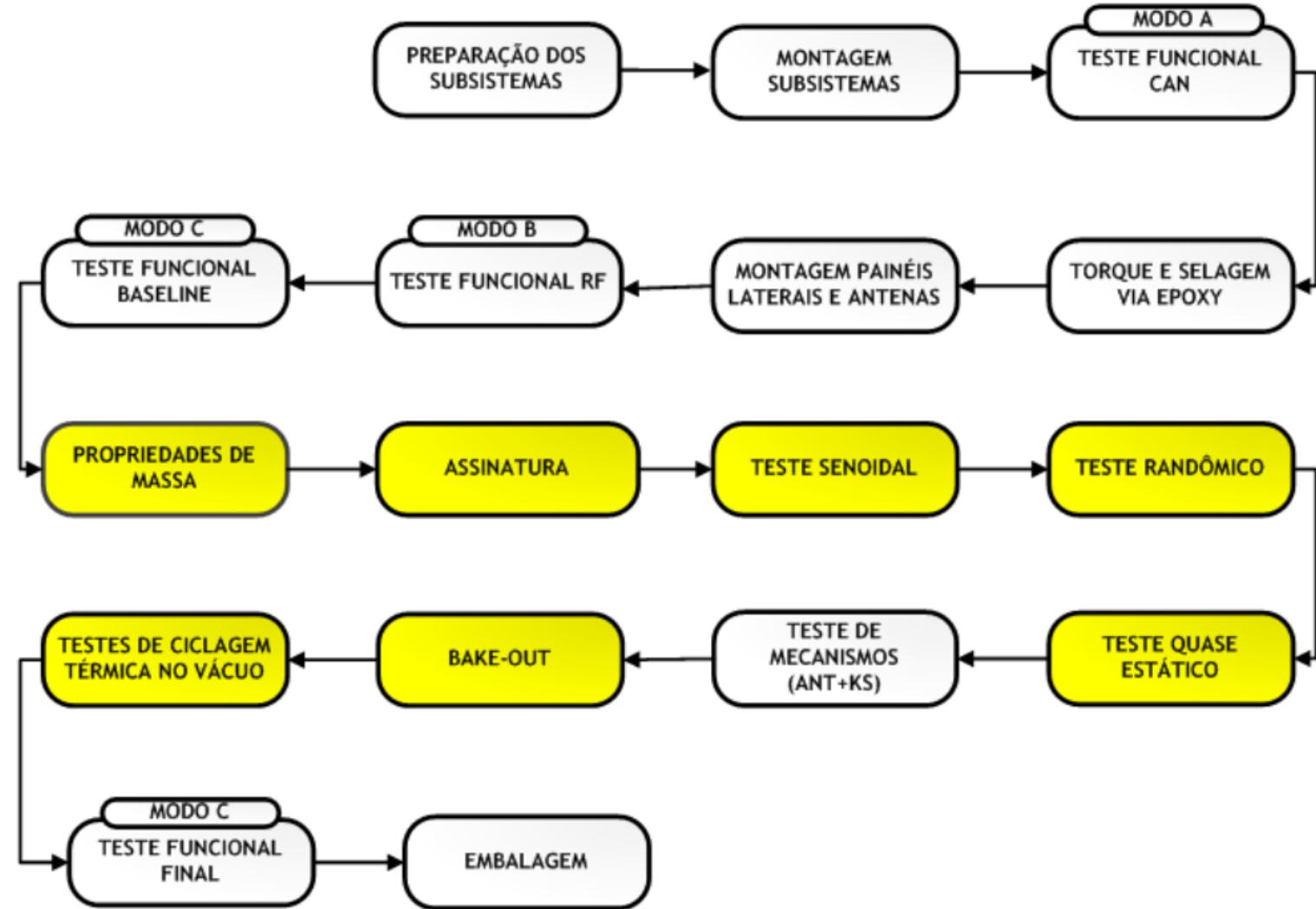


SEQUÊNCIA GERAL DE TESTES AMBIENTAIS -QM





SEQUÊNCIA GERAL DE TESTES AMBIENTAIS -FM



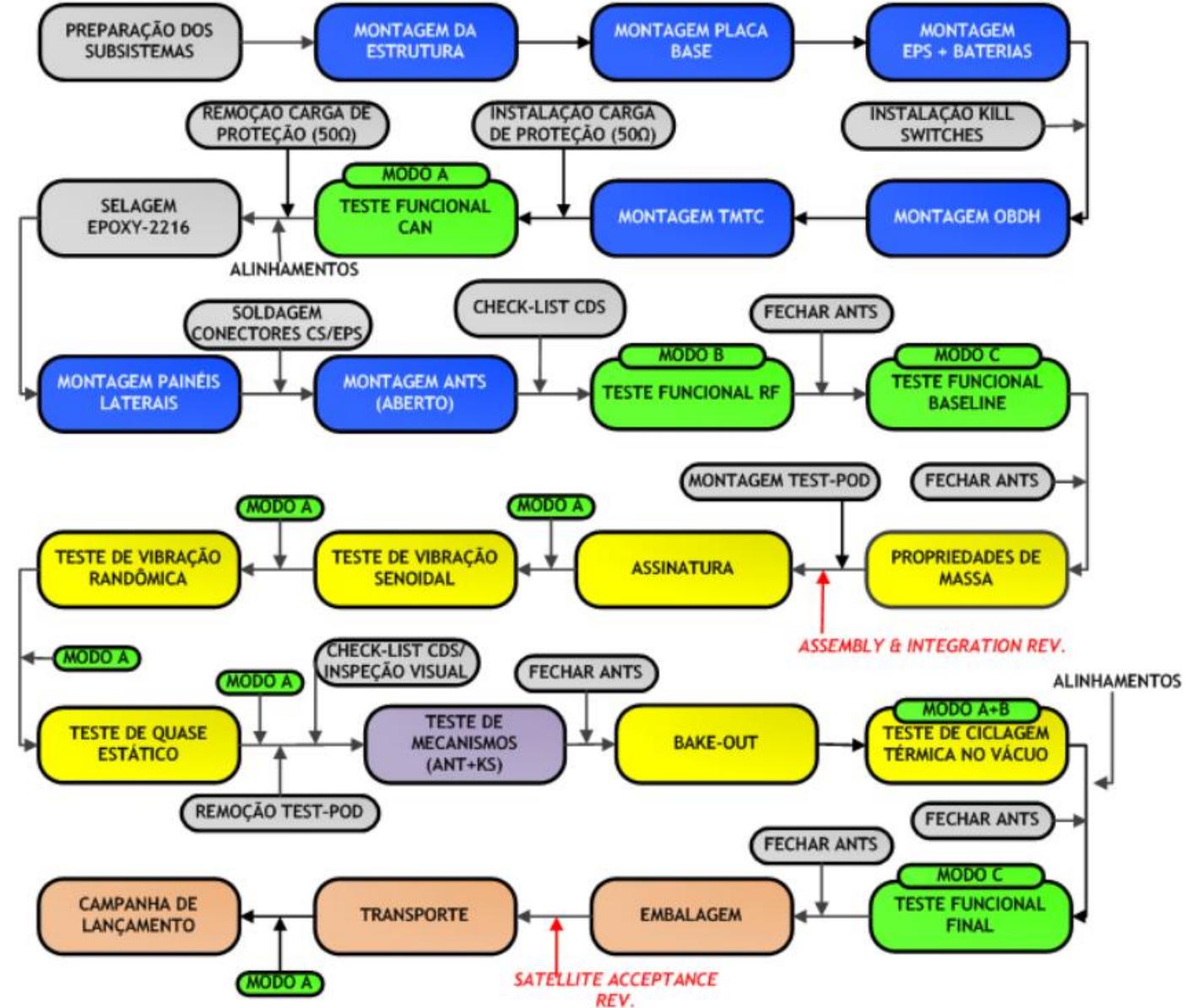


SEQUÊNCIA DETALHADA DE AIT –QM





SEQUÊNCIA DETALHADA DE AIT –FM





Class Ending



HOMEWORK

- Create a detailed AIT Sequence for the PFM of our example satellite.
 - Create a macro sequence
 - Detailed per activity: assembly, functional testing, environmental.
 - Describe each step: facility & resources involved
 - Use the dissertation of the AESP-14 as reference.
- **This must be presented in next class: Nov, 07th ~50min**
 - **Each subsystem representative will describe the tests related to its subsystem**